

<b>Notice of References Cited</b>		Application/Control No. 10/059,168	Applicant(s)/Patent Under Reexamination NAKAYMA ET AL.	
		Examiner Khiem D Nguyen	Art Unit 2823	Page 1 of 1

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*	B	US-5,620,924	04-1997	Takizawa et al.	427/108
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	M	US-			

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**NON-PATENT DOCUMENTS**

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